

<b>Notice of References Cited</b>	Application/Control No. 10/790,049	Applicant(s)/Patent Under Reexamination SASAKI ET AL.	
	Examiner A. Dexter Tugbang	Art Unit 3729	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	C	US-5,763,021	06-1998	Young et al.	427/585 x
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	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	N	JP 2-308533	12-1990	Japan	Kato et al	204/192.1
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**NON-PATENT DOCUMENTS**

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	U	Xie et al., "MR Sensor Oxidation Mechanism at High Temperature", IEEE Transactions on Magnetics, Vol. 35, No. 5, pages 2619-2621, September 1999.
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.